Unit: mm

TOSHIBA Transistor Silicon NPN · PNP Epitaxial Type (PCT Process) (Bias Resistor Built-in Transistor)

RN4986FE

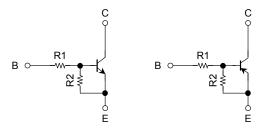
Switching, Inverter Circuit, Interface Circuit and Driver Circuit Applications

- Two devices are incorporated into an Extreme-Super-Mini (6-pin) package.
- Incorporating a bias resistor into a transistor reduces parts count.
 Reducing the parts count enables the manufacture of ever more compact equipment and lowers assembly cost.

Equivalent Circuit and Bias Resistor Values

Q2

Q1



R1: $4.7 \text{ k}\Omega$

R2: 47 kΩ

(Q1, Q2 common)

20.0±0.05 1.0±0.05 1.0±0.05 1.0±0.05 1.0±0.05

1.6±0.05 1.2±0.05

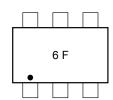
1. EMITTER 1 (E1)
2. BASE 1 (B1)
3. COLLECTOR 2 (C2)
4. EMITTER 2 (E2)

5. BASE 2 (B2) ES6 6. COLLECTOR 1 (C1)

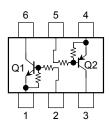
JEITA —
TOSHIBA 2-2N1G

Weight: 0.003 g (typ.)

Marking



Equivalent Circuit (top view)





Maximum Ratings (Ta = 25°C) (Q1)

Characteristics	Symbol	Rating	Unit
Collector-base voltage	V_{CBO}	50	V
Collector-emitter voltage	V _{CEO}	50	V
Emitter-base voltage	V _{EBO}	5	V
Collector current	IC	100	mA

Maximum Ratings (Ta = 25°C) (Q2)

Characteristics	Symbol	Rating	Unit
Collector-base voltage	V _{CBO}	-50	V
Collector-emitter voltage	V _{CEO}	-50	V
Emitter-base voltage	V _{EBO}	-5	V
Collector current	I _C	-100	mA

Maximum Ratings (Ta = 25°C) (Q1, Q2 common)

Characteristics	Symbol	Rating	Unit
Collector power dissipation	P _C (Note)	100	mW
Junction temperature	Tj	150	°C
Storage temperature range	T _{stg}	-55~150	°C

Note: Total rating



Electrical Characteristics (Ta = 25°C) (Q1)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Collector cut-off current	I _{CBO}	$V_{CB} = 50 \text{ V}, I_{E} = 0$	_	_	100	nA
Collector cut-on current	I _{CEO}	$V_{CE} = 50 \text{ V}, I_{B} = 0$	_	_	500	11/5
Emitter cut-off current	I _{EBO}	$V_{EB} = 5 V, I_C = 0$	0.074	_	0.138	mA
DC current gain	h _{FE}	V _{CE} = 5 V, I _C = 10 mA	80	_	_	
Collector-emitter saturation voltage	V _{CE (sat)}	$I_C = 5 \text{ mA}, I_B = 0.25 \text{ mA}$	_	0.1	0.3	V
Input voltage (ON)	V _{I (ON)}	$V_{CE} = 0.2 \text{ V}, I_{C} = 5 \text{ mA}$	0.7	_	1.3	V
Input voltage (OFF)	V _{I (OFF)}	$V_{CE} = 5 \text{ V}, I_{C} = 0.1 \text{ mA}$	0.5	_	0.8	V
Transition frequency	f _T	V _{CE} = 10 V, I _C = 5 mA	_	250	_	MHz
Collector output capacitance	C _{ob}	V _{CB} = 10 V, I _E = 0, f = 1 MHz	_	3	6	pF

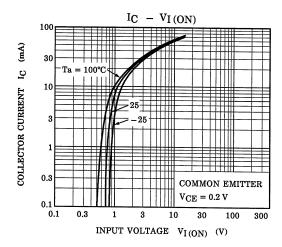
Electrical Characteristics (Ta = 25°C) (Q2)

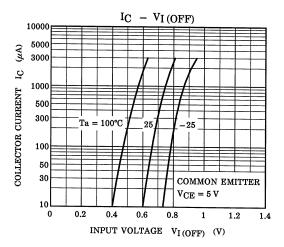
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Collector cut-off current	I _{CBO}	$V_{CB} = -50 \text{ V}, I_E = 0$	_	_	-100	nA
Collector cut-on current	ICEO	$V_{CE} = -50 \text{ V}, I_B = 0$	_	_	-500	ш
Emitter cut-off current	I _{EBO}	$V_{EB} = -5 \text{ V}, I_{C} = 0$	-0.074	_	-0.138	mA
DC current gain	h _{FE}	$V_{CE} = -5 \text{ V}, I_{C} = -10 \text{ mA}$	80	_	_	
Collector-emitter saturation voltage	V _{CE (sat)}	$I_C = -5 \text{ mA}, I_B = -0.25 \text{ mA}$	_	-0.1	-0.3	٧
Input voltage (ON)	V _{I (ON)}	$V_{CE} = -0.2 \text{ V}, I_{C} = -5 \text{ mA}$	-0.7	_	-1.3	٧
Input voltage (OFF)	V _{I (OFF)}	$V_{CE} = -5 \text{ V}, I_{C} = -0.1 \text{ mA}$	-0.5	_	-0.8	V
Transition frequency	f _T	$V_{CE} = -10 \text{ V}, I_{C} = -5 \text{ mA}$	_	200	_	MHz
Collector output capacitance	C _{ob}	$V_{CB} = -10 \text{ V}, I_E = 0, f = 1 \text{ MHz}$	_	3	6	pF

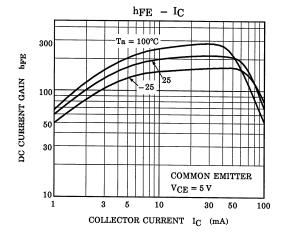
Electrical Characteristics (Ta = 25°C) (Q1, Q2 common)

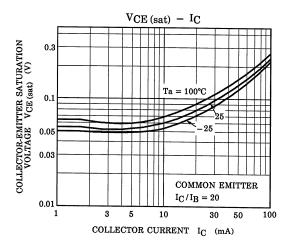
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Input resistor	R1	_	3.29	4.7	6.11	kΩ
Resistor ratio	R1/R2	_	0.09	0.1	0.11	

Q1

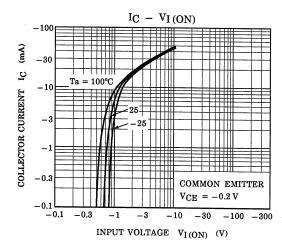


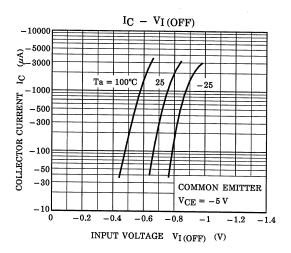


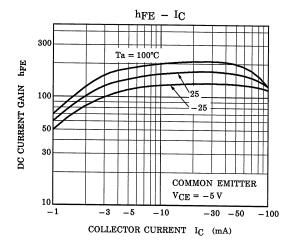


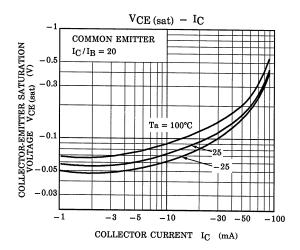


Q2









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